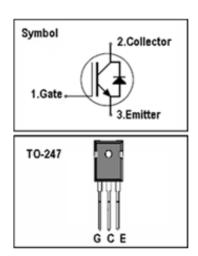
IGBT

Features

- 1200V,15A
- $V_{CE(sat)(typ.)}=1.8V@V_{GE}=15V,I_{C}=15A$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA



JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as Motor control, general inverter and other soft switching applications.



Absolute Maximum Ratings

| Symbol | Parameter | Value | Units | |
|------------------|--|---------------------------------------|-------|--|
| Vces | Collector-Emitter Voltage | 1200 | V | |
| V _{GES} | Gate-Emitter Voltage | <u>+</u> 30 V | | |
| | Continuous Collector Current (T _C =25 °C) | | Α | |
| IC | Ic Continuous Collector Current (Tc=100°C) | | Α | |
| Ісм | Pulsed Collector Current (Note 1) 45 | | Α | |
| I _F | Diode Continuous Forward Current (T _C =100 °C) | urrent (T _C =100 °C) 15 A | | |
| I _{FM} | Diode Maximum Forward Current (Note 1) | 45 A | | |
| t _{sc} | Short Circuit Withstand Time 10 | | us | |
| Б | Maximum Power Dissipation (T _C =25 °C) | 109 | W | |
| P _D | Maximum Power Dissipation (T _C =100 °C) | 43 | W | |
| TJ | Operating Junction Temperature Range | -55 to +150 °C | | |
| Tstg | Storage Temperature Range | -55 to +150 ℃ | | |

Thermal Characteristics

| Symbol | Parameter | Max. | Units | |
|--|---|------|-------|--|
| R _{th j-c} Thermal Resistance, Junction to case for IGBT 1.15 °C/ | | | | |
| R _{th j-c} | R _{th j-c} Thermal Resistance, Junction to case for Diode 1.5 °C/W | | °C/W | |
| R _{th j-a} | R _{th j-a} Thermal Resistance, Junction to Ambient 40 °C/ | | °C/W | |

Electrical Characteristics (Tc=25 °C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|----------------------|--------------------------------------|---|------|------|--------------|-------|
| BV _{CES} | Collector-Emitter Breakdown Voltage | $V_{GE} = 0V, I_{C} = 250uA$ | 1200 | - | - | V |
| I _{CES} | Collector-Emitter Leakage Current | V _{CE} = 1200V, V _{GE} = 0V | - | - | 100 | uA |
| I _{GES} | Gate Leakage Current, Forward | $V_{GE} = + 30V, V_{CE} = 0V$ | - | - | <u>+</u> 100 | nA |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{GE} = V_{CE}$, $I_C = 250uA$ | 5.1 | - | 6.9 | V |
| V _{CE(sat)} | Collector-Emitter Saturation Voltage | V _{GE} =15V, I _C = 15A | - | 1.8 | | V |
| Qg | Total Gate Charge | Vcc=960V | - | 62.4 | | nC |
| Qge | Gate-Emitter Charge | V _{GE} =15V | - | 8.6 | | nC |
| Qgc | Gate-Collector Charge | IC=15A | - | 42.2 | | nC |
| t d(on) | Turn-on Delay Time | Vcc=600V | - | 22 | - | ns |
| t r | Turn-on Rise Time | | - | 31 | - | ns |
| t d(off) | Turn-off Delay Time | V _{GE} =15V | - | 146 | - | ns |
| t f | Turn-off Fall Time | I _C =15Α R _G =15Ω | - | 210 | - | ns |
| Eon | Turn-on Switching Loss | Inductive Load | - | 0.7 | - | mJ |
| Eoff | Turn-off Switching Loss | T _C =25 ℃ | - | 0.8 | - | mJ |
| Ets | Total Switching Loss | | - | 1.5 | - | mJ |
| C _{ies} | Input Capacitance | V _{CE} =25V V _{GE} =0V | - | 1150 | - | pF |
| Coes | Output Capacitance | | - | 50 | - | pF |
| C _{res} | Reverse Transfer Capacitance | f = 1MHz | - | 10 | - | pF |

Electrical Characteristics of Diode (Tc=25°C unless otherwise noted)

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|----------------|-------------------------------------|------------------------|------|------|------|-------|
| V _F | Diode Forward Voltage | I _F =15A | - | 2.6 | 3.6 | V |
| trr | Diode Reverse Recovery Time | V _{CE} = 600V | - | 174 | | ns |
| Irr | Diode peak Reverse Recovery Current | I _F = 15A | - | 15.9 | | Α |
| Qrr | Diode Reverse Recovery Charge | dlF/dt = 800A/us | - | 953 | | nC |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature



Typical Performance Characteristics

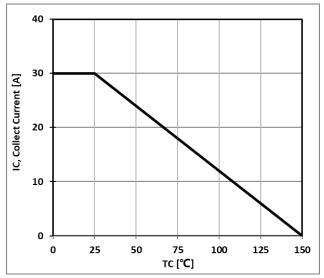


Figure 1: Maximum DC Collector Current VS. case temprature

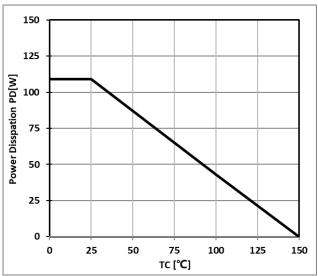


Figure 2: Power Dissipation VS. Case Temperature

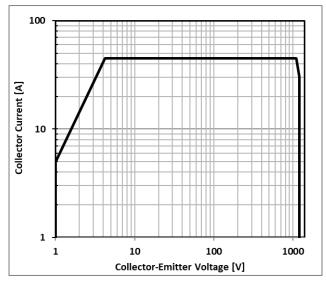


Figure 3: Reverse Bias SOA,TJ=125℃,VGE=15V

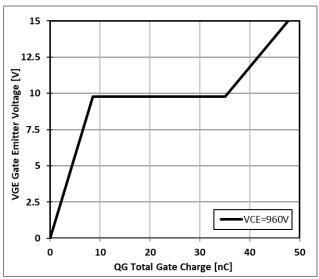


Figure 4: Typical Gate charge VS. VGE,IC=15A



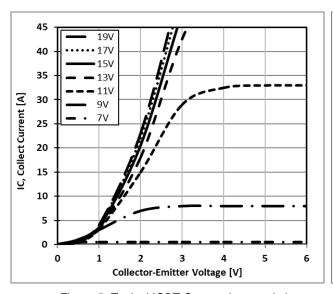


Figure 5: Typical IGBT Output characteristics, $TC=25^{\circ}C$;tp=300us

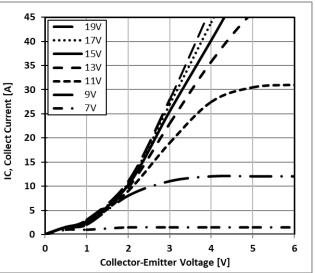


Figure 6: Typical IGBT Output characteristics, TC=150°C;tp=300us

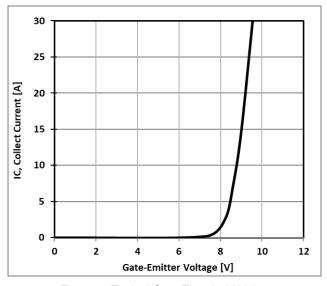


Figure 7: Typical Gate Threshold Voltage

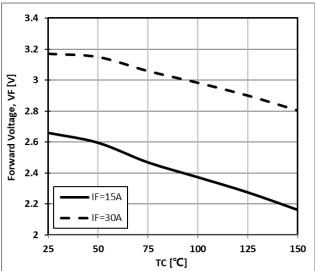


Figure 8: Typical Forward Voltage vs IF



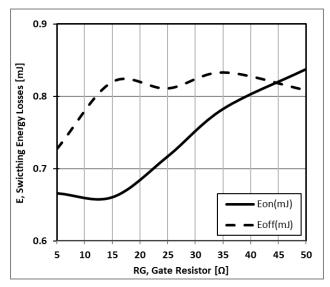


Figure 9: Typical Energy Loss VS. RG, TC=25°C, L=200uH,VCE=600V,VGE=15V,IC=15A

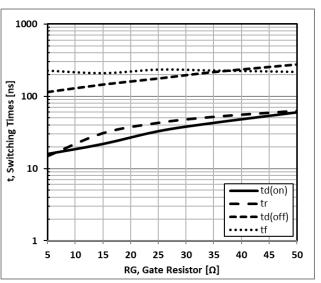


Figure 10: Typical Switching Time VS. RG, TC=25°C, L=200uH,VCE=600V,VGE=15V,IC=15A

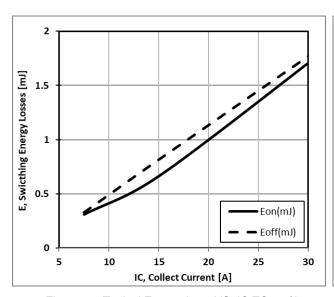


Figure 11: Typical Energy Loss VS. IC,TC=25 $^{\circ}$ C, L=200uH, VCE=600V, VGE=15V,RG=15 $^{\Omega}$

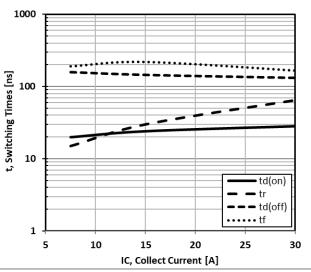


Figure 12: Typical Switching Time VS. IC,TC=25 $^{\circ}$ C, L=200uH,VCE=600V,VGE=15V,RG=15 $^{\circ}$



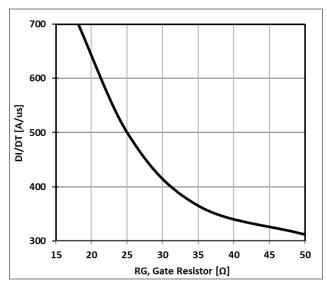


Figure 13: Typical Diode DI/DT VS. RG,TC=25°C VCC=600V, VGE=15V, IF=15A

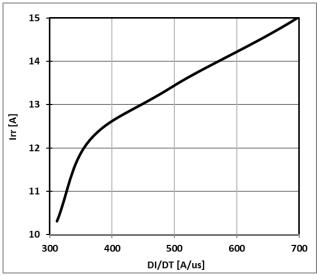


Figure 14: Typical Diode IRR VS. DI/DT,TC=25°C VCC=600V,VGE=15V, IF=15A

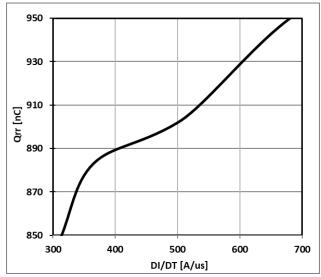


Figure 15: Typical Diode Qrr VS. DI/DT,TC=25℃ VCC=600V, VGE=15V, IF=15A

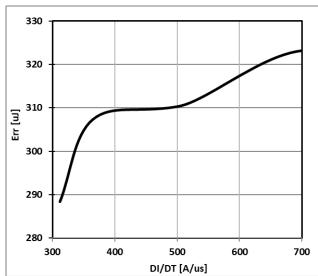
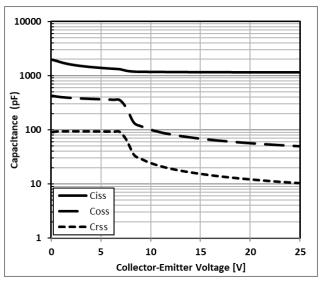


Figure 16: Typical Diode Err VS. DI/DT,TC=25 $^{\circ}$ C VCC=600V, VGE=15V, IF=15A





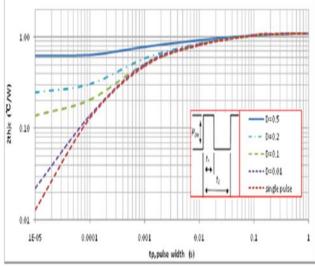
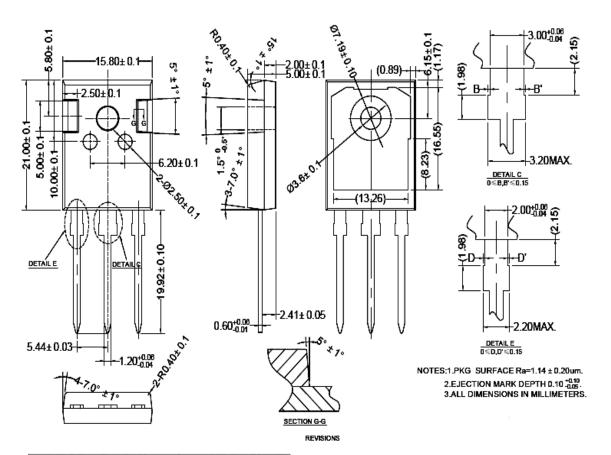


Figure 17: Typical Capacitance VS. VCE, VGE=0V,f=1MHz

Figure 18: Normalized transient thermal impedance junction-to-case



TO-247 PACKAGE OUTLINE



| 公差标注 | 会差值 | 表面粗糙度 |
|--------|--------|-----------|
| 0 | ±0.2 | Ra3.2~6.3 |
| 0.0 | ±0.1 | Ra1.6~3.2 |
| 0.00 | ±0.01 | Ra0.8~1.6 |
| 0.000 | ±0.005 | Ra0.4~0.8 |
| 0.0000 | ±0.002 | Ra0.2~0.4 |

0≤D,D'≤0.15

NOTES:1.PKG SURFACE Ra=1.14 ± 0.20um. 2.EJECTION MARK DEPTH 0.10 ±0.05 3.ALL DIMENSIONS IN MILLIMETERS.



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